

5 th Semester	REC5D006	Digital VLSI Design	L-T-P 3-0-0	3Credits
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MODULE-I

Introduction: Historical Perspective, VLSI Design Methodologies, VLSI Design Flow, Design Hierarchy, Concept of Regularity, Modularity and Locality, VLSI Design Styles, Computer-Aided Design Technology.

Fabrication of MOSFETs: Introduction, Fabrication Processes Flow – Basic Concepts, The CMOS n-Well Process, Layout Design Rules, Stick Diagrams, Full Customs Mask Layout Design.

MOS Transistor: The Metal Oxide Semiconductor (MOS) Structure, The MOS System under External Bias, Structure and Operation of MOS Transistor (MOSFET), MOSFET Current-Voltage Characteristics, MOSFET Scaling and Small-Geometry Effects, MOSFET Capacitance.

MODULE-II

MOS Inverters – Static Characteristics: Introduction, Resistive-Load Inverters, Inverters with n-Type MOSFET Load, CMOS Inverter.

MOS Inverters – Switching Characteristics and Interconnect Effects: Introduction, Delay-Time Definitions, Calculation of Delay-Times, Inverter Design with Delay Constraints, Estimation of Interconnect Parasitics, Calculation of Interconnect Delay, Switching Power Dissipation of CMOS Inverters.

Combinational MOS Logic Circuits: Introduction, MOS Logic Circuits with Depletion NMOS Loads, CMOS Logic Circuits, Complex Logic Circuits, CMOS Transmission Gates (Pass Gates).

MODULE-III

Sequential MOS Logic Circuits: Introduction, Behaviour of Bistable Elements, SR Latch Circuits, Clocked Latch and Flip-Flop Circuits, CMOS D-Latch and Edge Triggered Flip Flop.

Dynamic Logic Circuits: Introduction, Basic Principles of Pass Transistor Circuits, Voltage Bootstrapping, Synchronous Dynamic Circuit Techniques, Dynamic CMOS Circuit Techniques, High Performance Dynamic CMOS Circuits.

MODULE-IV

Design for Testability: Introduction, Fault Types and Models, Ad Hoc Testable Design Techniques, Scan-Based Techniques, Built-In Self-Test (BIST) Techniques, Current Monitoring IDDQ Test.

MODULE-V

Semiconductor Memories: Introduction, Dynamic Random Access Memory (DRAM), Static Random Access Memory (SRAM), Non-volatile Memory, Flash Memory.

Books:

- [1] *CMOS Digital Integrated Circuits: Analysis and Design*, Sung-Mo Kang and Yusuf Leblebici, Tata McGraw-Hill Publishing Company Limited, 3rd Edn, 2003.
- [2] *Principles of CMOS VLSI Design – a Systems Perspective*, K. Eshraghian and N.H.E. Weste, Addison Wesley, 2nd Edition, 1993.
- [3] *Digital Integrated Circuits– A Design Perspective*, Jan M. Rabaey, Anantha Chandrakasan, Borivoje Nikolic, PHI, 2nd Edn.
- [4] *Modern VLSI Design System – on – Chip Design*, Wayne Wolf, PHI, 3rd Edn.

- [5] VLSI Design, Debaprasad Das, Oxford University Press, New Delhi, 2010.
- [6] CMOS Logic Circuit Design, John P. Uyemura, Springer, 2001.
- [7] Digital Integrated Circuit Design, Ken Martin, Oxford University Press, 2000.
- [8] VLSI Design Technique for Analog and Digital Circuits, R L Geiger, TMH.

Digital Learning Resources:

Course Name: VLSI Design
Course Link: <https://nptel.ac.in/courses/117/101/117101058/>
Course Instructor: Prof. A.N. Chandorkar, IIT Bombay

Course Name: Digital VLSI Testing
Course Link: <https://nptel.ac.in/courses/117/105/117105137/>
Course Instructor: Prof. S, Chattopadhyay, IIT Kharagpur

Course Name: VLSI Technology
Course Link: <https://nptel.ac.in/courses/117/106/117106093/>
Course Instructor: Dr. Nandita Dasgupta, IIT Madras